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## **FDFM2P110**

# Integrated P-Channel PowerTrench® MOSFET and Schottky Diode

#### **General Description**

FDFM2P110 combines the exceptional performance of Fairchild's PowerTrench MOSFET technology with a very low forward voltage drop Schottky barrier rectifier in a MicroFET package.

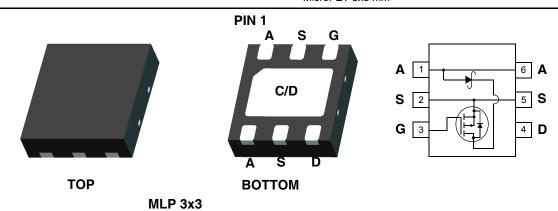
This device is designed specifically as a single package solution for Buck Boost. It features a fast switching, low gate charge MOSFET with very low on-state resistance.

### **Applications**

■ Buck Boost

#### **Features**

- -3.5 A, -20 V  $R_{DS(ON)} = 140 m\Omega$  @  $V_{GS} = -4.5 V$ 
  - $R_{DS(ON)} = 200 \text{m}\Omega$  @  $V_{GS} = -2.5 \text{ V}$
- Low Profile 0.8 mm maximun in the new package MicroFET 3x3 mm



## **Absolute Maximum Ratings** T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units	
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
V <sub>GSS</sub>	Gate-Source Voltage		±12	V
	Drain Current -Continuous	(Note 1a)	-3.5	А
<sup>I</sup> D	-Pulsed		-10	7
V <sub>RRM</sub>	Schottky Repetitive Peak Reverse voltage		20	V
Io	Schottky Average Forward Current	(Note 1a)	2	Α
D	Power dissipation (Steady State)	(Note 1a)	2	w
$P_{D}$			0.8	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

#### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	60	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	145	°C/W

### **Package Marking and Ordering Information**

Device Marking	Device	Reel Size	Tape Width	Quantity
2P110	FDFM2P110	7inch	12mm	3000 units

# Electrical Characteristics T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
B <sub>VDSS</sub>	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-20	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = -250μA, Referenced to 25°C	-	-11	-	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = -16V$	-	-	-1	μΑ
I <sub>GSS</sub>	Gate-Body Leakage,	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	-	±100	nA

#### On Characteristics (Note 2)

$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.6	-1.0	-1.5	V	
$\frac{\Delta V_{GS(TH)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$ , Referenced to 25°C	i	3	-	mV/°C	
	Static Drain-Source On-Resistance	$I_D = -3.5A, V_{GS} = -4.5V$	-	101	140		
R <sub>DS(ON)</sub>		$I_D = -3.0A$ , $V_{GS} = -2.5V$	ı	145	200	mΩ	
DS(ON)		$I_D = -3.5A$ , $V_{GS} = -4.5V$ , $T_J = 125^{\circ}C$	-	136	202	11122	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = -2.5V, V_{DS} = -5V$	-10	-	-	Α	
g <sub>FS</sub>	Forward Transconductance	$I_D = -3.5A, V_{DS} = -5V$	-	6	-	S	

## **Dynamic Characteristics**

C <sub>ISS</sub>	Input Capacitance	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1MHz	-	280	-	pF
C <sub>OSS</sub>	Output Capacitance		-	65	-	pF
C <sub>RSS</sub>	Reverse Transfer Capacitance	1 = 1WHZ		35	-	pF
$R_{G}$	Gate Resistance	f = 1MHz	-	7	•	Ω

## **Switching Characteristics** (Note 2)

t <sub>d(ON)</sub>	Turn-On Delay Time		-	8	16	ns
t <sub>r</sub>	Turn-On Rise Time	V <sub>DD</sub> = -10V, I <sub>D</sub> = -1A	-	12	22	ns
t <sub>d(OFF)</sub>	Turn-Off Delay Time	$V_{GS} = -4.5V, R_{GEN} = 16\Omega$	-	11	20	ns
t <sub>f</sub>	Turn-Off Fall Time		-	3.2	6.4	ns
$Q_g$	Total Gate Charge	V 10V I 0.5A	-	3	4	nC
$Q_{gs}$	Gate-Source Charge	$V_{DS} = -10V, I_{D} = -3.5A,$ $V_{GS} = -4.5V$	-	0.7	-	nC
$Q_{gd}$	Gate-Drain Charge		-	1	-	nC

## **Drain-Source Diode Characteristics and Maximum Ratings**

I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current			-	-2	Α
$V_{SD}$	Drain-Source Diode Forward Voltage V <sub>GS</sub> = 0V, I <sub>S</sub> = -2 A (Note 2)		-	-0.9	-1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>E</sub> = -3.5A, dI <sub>E</sub> /dt=100A/μs	-	13	-	ns
$Q_{rr}$	Diode Reverse Recovery Charge	TiF= -3.3A, diF/di=100A/μS	ı	3	-	nC

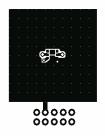
## **Schottky Diode Characteristic**

V <sub>R</sub>	Reverse Voltage	I <sub>R</sub> = 1mA		20	-	-	V
I_	Reverse Leakage	V <sub>R</sub> = 5V	$T_J = 25^{\circ}C$	-	-	100	μΑ
<sup>I</sup> R	neverse Leakage		$T_J = 100^{\circ}C$			10	mA
$V_{F}$	Forward Voltage	I <sub>F</sub> = 1A	$T_J = 25^{\circ}C$	-	0.32	0.39	V

## **Electrical Characteristics** $T_A = 25$ °C unless otherwise noted

#### Notes

1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta CA}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 60°C/W when mounted on a 1in² pad of 2 oz copper

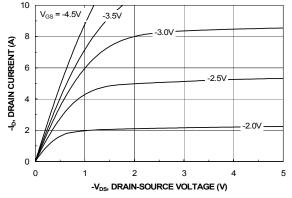


b) 145°C/W whe mounted on a minimum pad of 2 oz copper

Scale 1: 1 on letter size paper

**2.** Pulse Test: Pulse Width < 300  $\mu$ s, Duty Cycle < 2.0%

## **Typical Characteristics**



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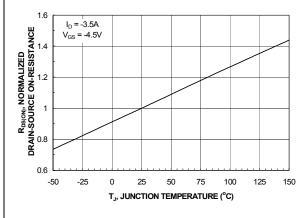
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Figure 1. On-Region Characteristics

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage



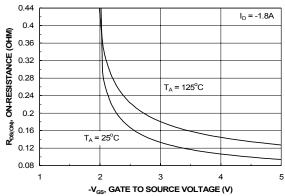
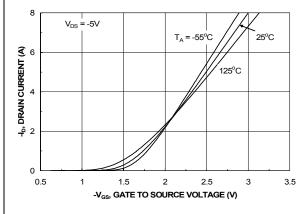


Figure 3. On-Resistance Variation with Temperature

Figure 4. On-Resistance Variation with Gate-to-Source Voltage



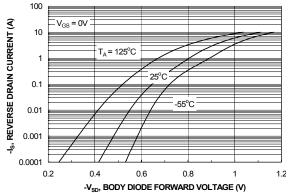
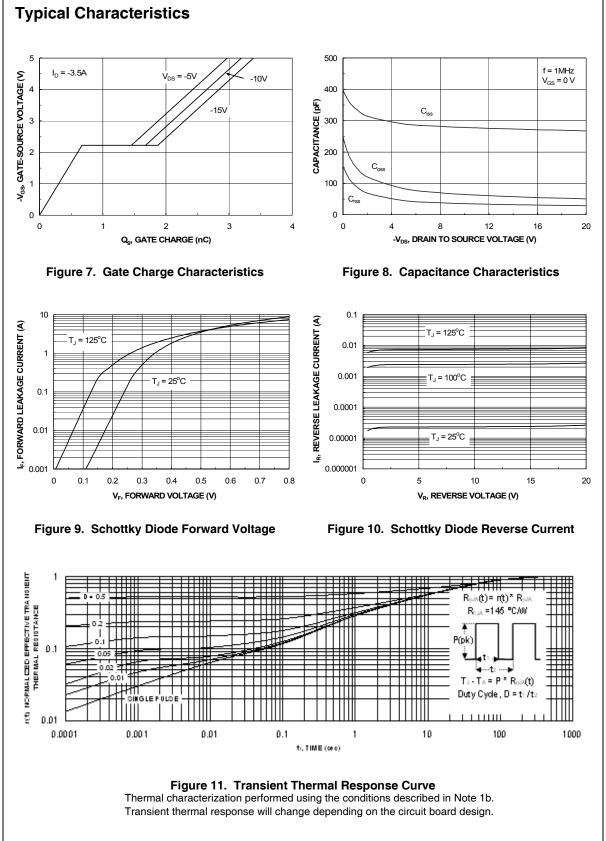
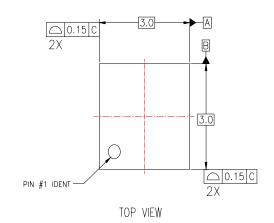
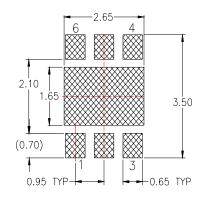


Figure 5. Transfer Characteristics

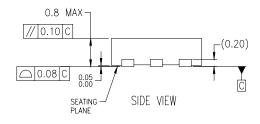
Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

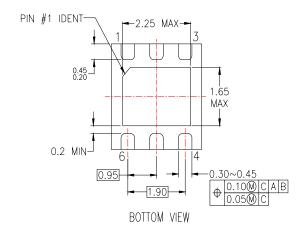


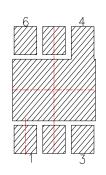




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#### NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-229, VARIATION WEEA, DATED 11/2001
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

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